# **Power MOSFET**

-20 V, -8.2 A, Single P-Channel, 2.0x2.0x0.55 mm UDFN Package

### Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- Ultra Low R<sub>DS(on)</sub>
- ESD Diode-Protected Gate
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- Optimized for Power Management Applications for Portable Products, such as Cell Phones, Media Tablets, PMP, DSC, GPS, and Others
- Battery Switch
- High Side Load Switch

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise stated)

Pa	Symbol	Value	Unit		
Drain-to-Source Vo	ltage		V <sub>DSS</sub>	-20	V
Gate-to-Source Vol	tage		V <sub>GS</sub>	±8.0	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-8.2	А
Current (Note 1) Continuous Drain	State	T <sub>A</sub> = 85°C		-5.9	
Current (Note 1)	t ≤ 5 s	T <sub>A</sub> = 25°C		-12.2	
Power Dissipa- tion (Note 1)	Steady State	$T_A = 25^{\circ}C$	P <sub>D</sub>	1.7	W
	t ≤ 5 s	$T_A = 25^{\circ}C$		3.8	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-5.1	А
Current (Note 2)	State	T <sub>A</sub> = 85°C		-3.7	
Power Dissipation (	Note 2)	$T_A = 25^{\circ}C$	PD	0.7	W
Pulsed Drain Curre	nt	tp = 10 μs	I <sub>DM</sub>	-25	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
ESD (HBM, JESD22–A114)			V <sub>ESD</sub>	2000	V
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	-1.7	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

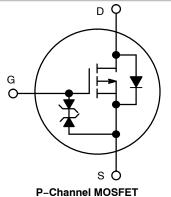


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### MOSFET

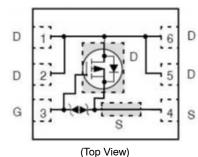
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX				
	18 mΩ @ −4.5 V					
-20 V	25 mΩ @ –2.5 V	-8.2 A				
201	50 mΩ @ –1.8 V	0.27				
	90 mΩ @ –1.5 V					











## ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

### THERMAL RESISTANCE RATINGS

Parameter		Max	Unit
Junction-to-Ambient – Steady State (Note 3)	R <sub>θJA</sub>	72	
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	R <sub>θJA</sub>	33	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\thetaJA}$	189	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	<sub>D</sub> = –250 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA	∧, ref to 25°C		+10		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -20 V	$T_J = 25^{\circ}C$			-1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	/ <sub>GS</sub> = ±5.0 V			±5	μA

**ON CHARACTERISTICS** (Note 5)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -250 \ \mu A$	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			3.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5$ V, $I_D = -7.0$ A		14.6	18	mΩ
		$V_{GS}$ = -2.5 V, I <sub>D</sub> = -5.0 A		19	25	
		$V_{GS} = -1.8$ V, $I_D = -3.0$ A		25	50	
		$V_{GS} = -1.5 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$		40	90	
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = -5 \text{ V}, \text{ I}_{D} = -3.0 \text{ A}$		40		S

#### **CHARGES, CAPACITANCES & GATE RESISTANCE**

Input Capacitance	C <sub>ISS</sub>		2240	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = -15 V	240	
Reverse Transfer Capacitance	C <sub>RSS</sub>		210	
Total Gate Charge	Q <sub>G(TOT)</sub>		28	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V};$ $I_D = -4.0 \text{ A}$	1.0	
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = -4.0$ A	2.9	
Gate-to-Drain Charge	Q <sub>GD</sub>		8.8	

SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		8.6	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> = -15 V,	15	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$\overline{I}_D = -4.0 \text{ A}, \ \overline{R}_G = 1 \Omega$	150	
Fall Time	t <sub>f</sub>		88	

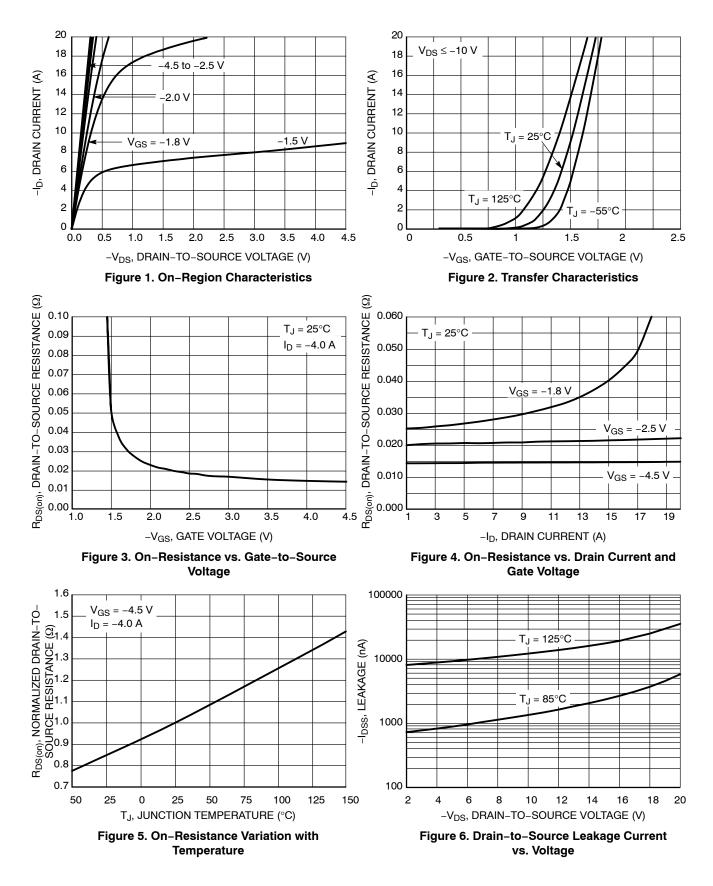
#### **DRAIN-SOURCE DIODE CHARACTERISTICS**

Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_{\rm J} = 25^{\circ}C$	0.63	1.0	V
		I <sub>S</sub> = -1.0 A	T <sub>J</sub> = 125°C	0.50		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/µs, I <sub>S</sub> = −1.0 A		26.1		ns
Charge Time	t <sub>a</sub>			10.2		
Discharge Time	t <sub>b</sub>			15.9		
Reverse Recovery Charge	Q <sub>RR</sub>			12		nC

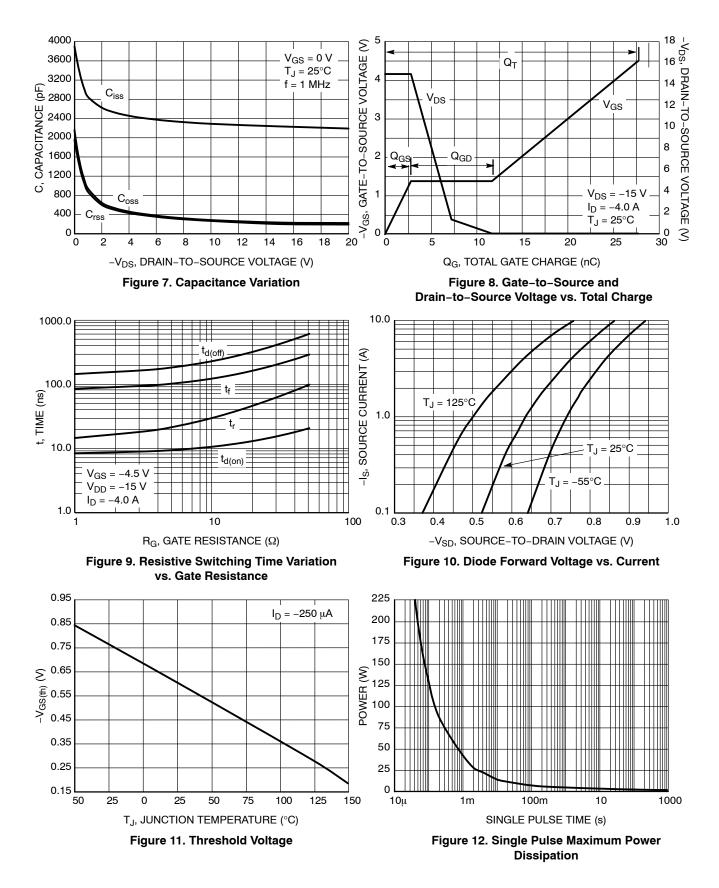
5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

6. Switching characteristics are independent of operating junction temperatures.

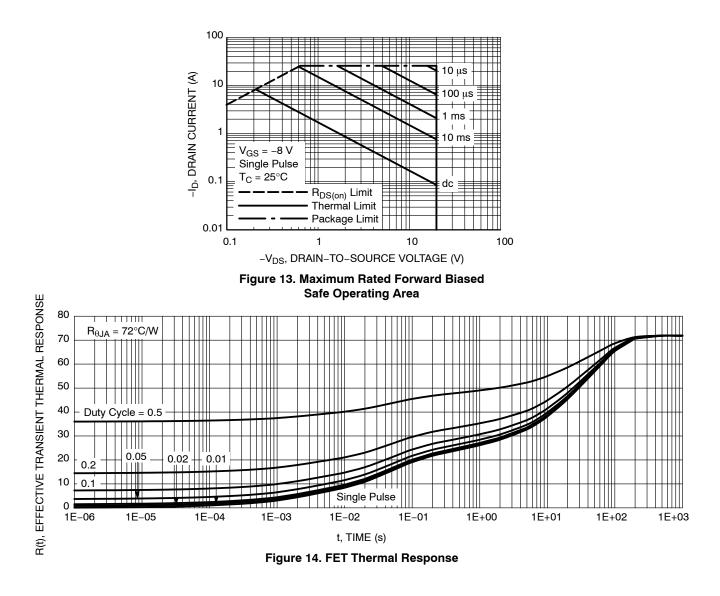
### **TYPICAL CHARACTERISTICS**



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### **DEVICE ORDERING INFORMATION**

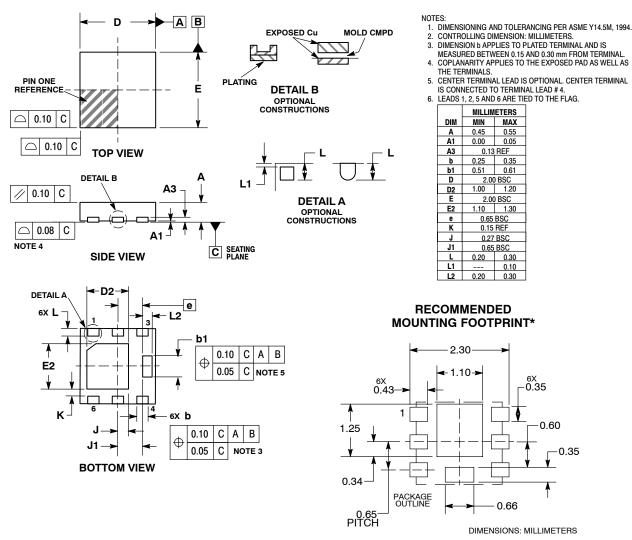
Device	Package	Shipping <sup>†</sup>
NTLUS3A18PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A18PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A18PZTCG	UDFN6 (Pb–Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

### UDFN6 2x2, 0.65P CASE 517BG

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\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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#### PUBLICATION ORDERING INFORMATION

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